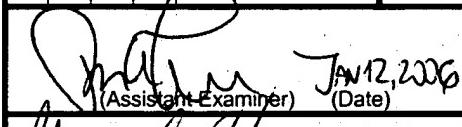
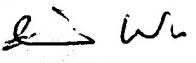


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/771,396	HOJO ET AL.
	Examiner Rip A. Lee	Art Unit 1713

ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
525	333.1	525	332.6	333.5							
INTERNATIONAL CLASSIFICATION				524	161	157	157	161	173	201	202
C	0	8	F	136/08	524	203					
C	0	8	F	12/08							
C	0	8	K	5/42							
C	0	8	K	5/36							
				1							
 (Assistant Examiner) (Date)				 DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner) (Date)				Total Claims Allowed: 11 1 / 12 / 06			
 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. ---		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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